

# UNBELIEVABLY POWERFUL. INSANELY EASY.



WaveRunner 8000 500 MHz - 4 GHz Oscilloscopes

Superior User Experience

Powerful, Deep Toolbox

**Exceptional Serial Data Tools** 

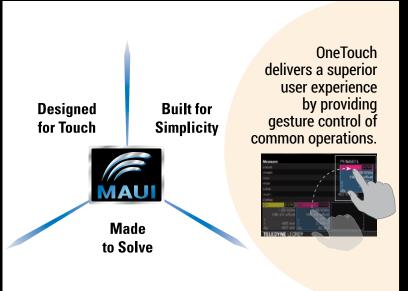
"M" Models for Maximum Sample Rate and Memory The WaveRunner 8000 combines a superior oscilloscope experience with an extensive toolbox to deliver faster time to insight.



# UNBELIEVABLY POWERFUL. INSANELY EASY.

WaveRunner 8000







The WaveRunner 8000 combines a superior oscilloscope experience with an extensive toolbox to deliver faster time to insight.

- 1 Superior User Experience
- 2 Powerful, Deep Toolbox
- 3 Exceptional Serial Data Tools
- "M" Models for Maximum Sample Rate and Memory



# Faster Time to Insight

# Insight alone is not enough.

Markets and technologies change too rapidly.

The timing of critical design

decisions is significant.

Time to insight is what matters.



# MAUI - SUPERIOR USER EXPERIENCE



MAUI – Most Advanced User Interface was developed to put all the power and capabilities of the modern oscilloscope right at your fingertips. Designed for touch; all important oscilloscope controls are accessed through the intuitive touch screen. Built for simplicity; time saving shortcuts and intuitive dialogs simplify setup. Made to solve; a deep set of debug and analysis tools helps identify problems and find solutions quickly.

# Designed for Touch

MAUI is designed for touch. Operate the oscilloscope just like a phone or tablet with the most unique touch screen features on any oscilloscope. All important controls are always one touch away. Touch the waveform to position or zoom in for more details using intuitive actions.

# **Built for Simplicity**

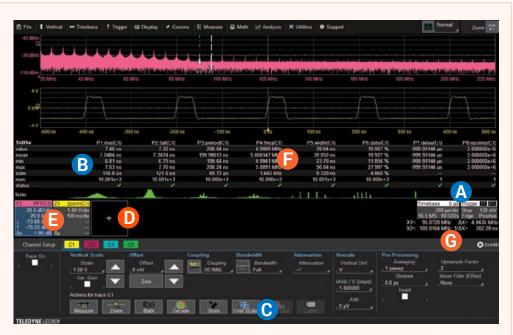
MAUI is built for simplicity. Basic waveform viewing and measurement tools as well as advanced math and analysis capabilities are seamlessly integrated in a single user interface. Time saving shortcuts and intuitive dialogs simplify setup and shorten debug time.

# Made to Solve

MAUI is made to solve. A deep set of integrated debug and analysis tools help identify problems and find solutions quickly. Unsurpassed integration provides critical flexibility when debugging. Solve problems fast with powerful analysis tools.

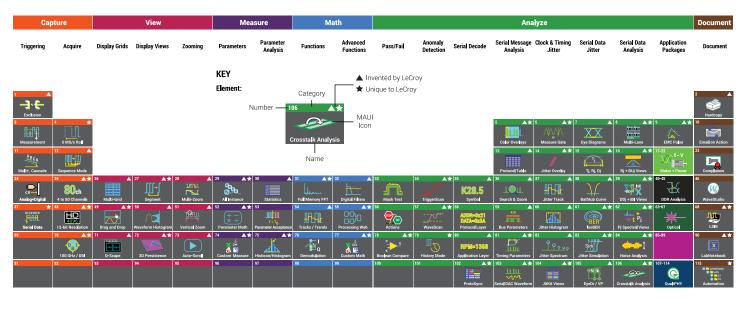
# MAUI with OneTouch

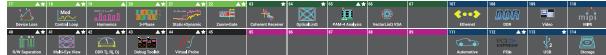
MAUI with OneTouch introduces a new paradigm for oscilloscope user experience. Dramatically reduce setup time with revolutionary drag and drop actions to copy and setup channels, math functions, and measurement parameters without lifting a finger. Use common gestures like drag, drop, and flick to instinctively interact with the oscilloscope. Quickly enable a new channel, math or measurement using the "Add New" button and simply turn off any trace or parameter with a flick of the finger. These OneTouch innovations provide unsurpassed efficiency in oscilloscope operation.



- Channel, timebase, and trigger descriptors provide easy access to controls without navigating menus.
- B Configure parameters by touching measurement results.
- Shortcuts to commonly used functions are displayed at the bottom of the channel, math and memory menus.
- Use the "Add New" button for one-touch trace creation.
- Drag to change source, copy setup, turn on new trace, or move waveform location.
- Drag to copy measurement parameters to streamline setup process.
- Orag to quickly position cursors on a trace.

# **POWERFUL, DEEP TOOLBOX**





# Our Heritage

Teledyne LeCroy's 50+ year heritage has its origins in the high-speed collection of data in the field of high-energy physics, and the processing of long records to extract meaningful insight. We didn't invent the oscilloscope, but we did invent the digital oscilloscope, which can take full advantage of advanced digital signal processing and waveshape analysis tools to provide unparalleled insight.

# Our Obsession

Our developers are true to our heritage — they are more obsessed with making better and smarter tools than anybody else. Our tools and operating philosophy are standardized across much of our product line for a consistent user experience. Our mission is to help you use these tools to understand problems, including the ones you don't even know you have. Our deep toolbox inspires insight; and your moment of insight is our reward.

# **Our Invitation**

Our Periodic Table of Oscilloscope
Tools provides a framework to
understand the toolsets that Teledyne
LeCroy has created and deployed in
our oscilloscopes. Visit our interactive
website to learn more about what we
offer and how we can help you develop
and debug more efficiently.

teledynelecroy.com/tools

# **WAVERUNNER 8000 AT A GLANCE**

The WaveRunner 8000 combines a superior oscilloscope experience with an extensive toolbox to shorten debug time. MAUI with OneTouch includes the most unique touch features on any oscilloscope providing unsurpassed efficiency in oscilloscope operation. Offering 500 MHz - 4 GHz of bandwidth, 40 GS/s sample rate, long memory, MAUI — Most Advanced User Interface, and a versatile toolset make the WaveRunner 8000 unbelievably powerful and insanely easy to use.

# **Key Features**

500 MHz - 4 GHz bandwidths

Up to 40 GS/s sample rate

### **MAUI** with OneTouch

- Designed for touch
- Built for simplicity
- Made to solve

### **Advanced Tools**

- Jitter and Timing Analysis Capabilities
- WaveScan Search and Find
- LabNotebook Documentation and Report Generation
- History Mode Waveform Playback

# **Optional Software Packages**

- Advanced Customization
- Digital Filtering
- Spectrum Analysis
- Device and Switching Power Supply Analysis
- Comprehensive set of serial data analysis, debug, validation and compliance tools

# 16 digital channels with 1.25 GS/s

- Analog and Digital Cross-Pattern Triggering
- Digital Pattern Search and Find
- Analog and Digital Timing Measurements
- Logic Gate Emulation
- Activity Indicators



# **Superior User Experience**

The WaveRunner 8000 with MAUI
OneTouch sets the standard for
oscilloscope user experience by
providing the most unique touch
features on any oscilloscope. Common
gestures are used to instinctively interact
with the oscilloscope and dramatically
reduce setup time. Convenience and
efficiency are optimized - all common
operations can be performed with one
touch and do not require opening and
closing of pop-up dialogs or menus.

# **Exceptional Serial Data Tools**

A wide a variety of application packages are available to meet all serial data test challenges, ranging from automated compliance packages to flexible debug toolkits. A suite of protocol specific measurement and eye diagram packages are available to complement the industry's most intuitive trigger and decode packages.

# **Powerful, Deep Toolbox**

The standard collection of math, measurement, debug, and documentation tools provides unsurpassed analysis capabilities. Application-specific packages enable streamlined debugging for common design/validation scenarios. The advanced customization option (XDEV) enables user-defined parameters and math functions providing unique and limitless analysis capability.

# "M" Models for Maximum Sample Rate and Memory

An industry leading 40 GS/s sample rate allows for a detailed edge reconstruction even for signals with the fastest rise times. Long memory allows for maximum sample rate to be maintained in longer timebases. Deep memory of 128 Mpts is ideal for debugging long term behavior on high speed serial data buses.



# **Key Attributes**

- 1. 12.1" Widescreen (16 x 9) high resolution WXGA color touch screen display
- 2. MAUI with OneTouch optimized for convenience and efficiency
- **3.** "Add New" button for fast waveform creation
- **4.** Serial trigger captures signals up to 3 Gb/s
- "Push" Knobs All knobs have push functionality that provide shortcuts to common actions such as Set to Variable, Find Trigger Level, Zero Offset, and Zero Delay

- 6. Waveform Control Knobs –
  Control channel, zoom, math
  and memory traces with the
  multiplexed vertical and
  horizontal knobs
- Dedicated Cursor Knob –
   Select type of cursor, position
   them on your signal, and read
   values without ever opening
   Ava menu
- **8.** Dedicated buttons to quickly access popular debug tools.
- Mixed Signal Capability Debug complex embedded designs with integrated 16 channel mixed signal capability

- **10.** Reference Clock Input/Output connectors for connecting to other equipment
- **11.** Easy connectivity with four USB 3.1 ports and three USB 2.0 ports
- **12.** USBTMC (Test and Measurement Class) over USB 3.1 for fast data offload

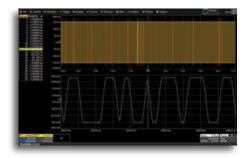


# **ADVANCED TOOLS FOR WAVEFORM ANALYSIS**

# Serial Trigger, Decode, Measure/Graph, and Eye Diagrams

Isolate events using the serial bus trigger and view color-coded protocol information on top of analog or digital waveforms. Timing and bus measurements allow quick and easy characterization of a serial data system. Serial (digital) data can be extracted and graphed to monitor system performance over time. Identify physical layer anomalies with eye diagram mask testing and mask failure locator.





# WaveScan Advanced Search and Find Tool

Quickly scan analog, digital or parallel bus signals for runts, glitches or other anomalies with WaveScan.



# **Jitter and Timing Analysis**

Understand system jitter performance of clock and data signals.
Enable histograms, tracks, and spectrum plots to visualize the data.



# **Spectrum Analyzer Mode**

View signal details in the frequency domain with a spectrum analyzer style user interface.

# **Sequence Mode Acquisition**

Capture many fast pulses in quick succession or events separated by long periods of time.

# History Mode Waveform Playback

Scroll back in time to isolate anomalies that have previously been captured to quickly find the source of the problem.

# LabNotebook Documentation and Report Generation Tool

Save all results and data with a single button press and create custom reports with LabNotebook.

# **POWERFUL MIXED SIGNAL CAPABILITIES**

Teledyne LeCroy's WaveRunner 8000-MS mixed signal oscilloscope combines the high-performance analog channels of the WaveRunner 8000 with the flexibility of 16 digital inputs. In addition, the many triggering and decoding options turn the WaveRunner 8000-MS into an all-in-one analog, digital, serial debug machine.

# High-performance 16-Channel Mixed Signal Capability

With embedded systems growing more complex, powerful mixed signal debug capabilities are an essential part of modern oscilloscopes. The 16 integrated digital channels and set of tools designed to view, measure and analyze analog and digital signals enable fast debugging of mixed signal designs.

# **Advanced Digital Debug Tools**

Using the powerful parallel pattern search capability of WaveScan, patterns across many digital lines can be isolated and analyzed. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

Use a variety of the many timing parameters to measure and analyze the characteristics of digital busses. Powerful tools like tracks, trends, statistics and histicons provide additional insight and help find anomalies.

Quickly see the state of all the digital lines at the same time using convenient activity indicators.

Simulate complete digital designs using logic gate emulation. When used with the web editor, many logic gates can be combined together in one math function to simulate complex logic designs. Choose from AND, OR, NAND, NOR, XOR, NOT and D Flip Flop gates.

# **Extensive Triggering**

Flexible analog and digital cross-pattern triggering across all 20 channels provides the ability to quickly identify and isolate problems in an embedded system. Event triggering can be configured to arm on an analog signal and trigger on a digital pattern.



# STANDARD TOOLS FOR ADVANCED ANALYSIS



# **WaveScan Advanced Search**

WaveScan provides powerful isolation capabilities that hardware triggers can't provide. WaveScan allows searching analog, digital or parallel bus signal in a single acquisition using more than 20 different criteria. Or, set up a scan condition and scan for an event over hours or even days.

Since the scanning "modes" are not simply copies of the hardware triggers, the utility and capability is much higher. For instance, there is no "frequency" trigger in any oscilloscope, yet WaveScan allows for "frequency" to be quickly "scanned." This allows the user to accumulate a data set of unusual events that are separated by hours or days, enabling faster debugging.

When used in multiple acquisitions, WaveScan builds on the traditional Teledyne LeCroy strength of fast processing of data. Quickly scan millions of events looking for unusual occurrences, and do it much faster and more efficiently than other oscilloscopes can. Found events can be overlaid with the ScanOverlay to provide a quick comparison of events; measurement based scans populate the ScanHistogram to show the statistical distribution of the events.

Additionally, digital lines can be used as inputs into WaveScan to isolate and analyze patterns using the powerful parallel pattern search capability. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

# **Advanced Waveform Capture** with Sequence Mode

Use Sequence mode to store up to 15,000 triggered events as "segments" into memory. This can be ideal when capturing many fast pulses in quick succession or when capturing events separated by long time periods. Sequence mode provides timestamps for each acquisition and minimizes dead-time between triggers to less than 1 µs. Combine Sequence mode with advanced triggers to isolate rare events over time and analyze afterwards.

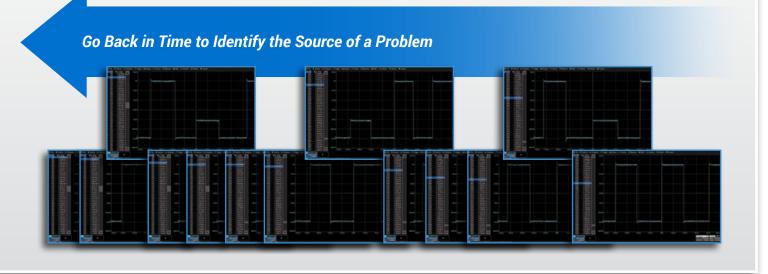
# **Advanced Math and Measure**

With many math functions and measurement parameters available, the WaveRunner 8000 can measure and analyze every aspect of analog and digital waveforms. Beyond just measuring waveforms, the WaveRunner 8000 provides statistics, histicons, tracks and trends to show how waveforms change over time. Measurements and math functions can be quickly copy and setup using MAUI with OneTouch.



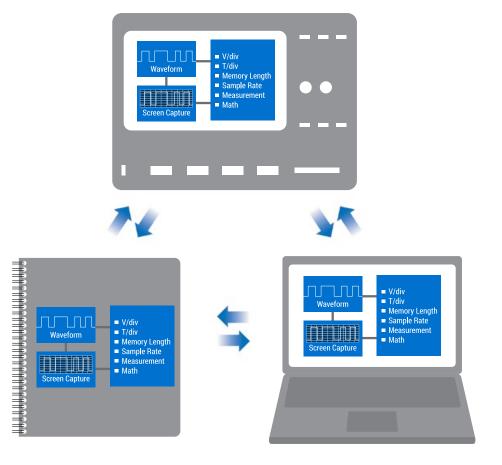
# **History Mode Waveform Playback**

Scroll back in time using History Mode to view previous waveforms and isolate anomalies. Use cursors and measurement parameters to quickly find the source of problems. History mode is always available with a single button press, no need to enable this mode and never miss a waveform.



# LabNotebook

The LabNotebook feature of WaveRunner 8000 is the ideal documentation tool. LabNotebook automatically saves all displayed waveforms, oscilloscope setup file, and a screen with a single button press, eliminating the need to navigate multiple menus to save all these files independently. Report files can be annotated and shared with colleagues to fully document all results. Easily recreate experiments and compare tests results amongst colleagues across the world by recalling LabNotebook files back onto the oscilloscope or view on a PC using WaveStudio.



# MOST COMPLETE SERIAL DATA DEBUG AND VALIDATION

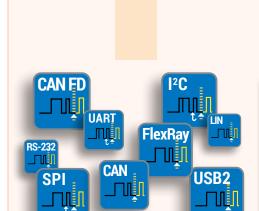
The WaveRunner 8000 features the widest range and most complete serial data debug and validation solutions.

- Triggering
- Decoding
- Measurement and Graphing
- Eye Diagram and Physical Layer Analysis

Various compliance test, synchronized protocol decode views, and other advanced jitter analysis tools are also available.

# Solutions address the following markets and applications:

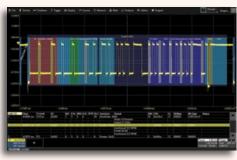
- Embedded Computing
- Automotive
- Industrial
- Military and Avionics
- Peripherals
- Memory
- Handset/Mobile/Cellular
- High Speed Computing
- Data Storage
- Serial Digital Audio



# **Trigger**

Powerful, flexible triggers designed by people who know the standards, with the unique capabilities you want to isolate unusual events. Conditional data triggering permits maximum flexibility and highly adaptable error frame triggering is available to isolate error conditions. Frame definition allows grouping of UART or SPI packets into message frames for customization.





### Decode

Decoded protocol information is color-coded to specific portions of the serial data waveform and transparently overlaid for an intuitive, easy-to-understand visual record. All decoded protocols are displayed in a single time-interleaved table. Touch a row in the interactive table to quickly zoom to a packet of interest and easily search through long records for specific protocol events using the built-in search feature.

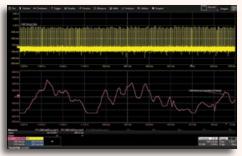


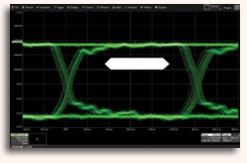
# **ProtoSync**

ProtoSync combines the oscilloscope view with a simultaneous view of data link layer decodes on the same instrument. This combination makes ProtoSync very effective in debugging protocol-specific negotiation rates.

Compatible with PCI Express, USB 2.0, USB2-HSIC, SAS, SATA, and Fibre Channel.







# Measure/Graph

Quickly validate cause and effect with automated timing measurements to or from an analog signal or another serial message. Make multiple measurements in a single long acquisition to quickly acquire statistics during cornercase testing. Serial (digital) data can be extracted to an analog value and graphed to monitor system performance over time, as if it was probed directly. Complete validation faster and gain better insight.

# **Eye Diagram**

Rapidly display an eye diagram of your packetized low-speed serial data signal without additional setup time. Use eye parameters to quantify system performance and apply a standard or custom mask to identify anomalies. Mask failures can be indicated and can force the scope into Stop mode.

SDAII or DDR Debug (optional) create eye diagrams of streaming NRZ serial data or DDR signals, and measure and analyze jitter breakdown.

# QualiPHY / Compliance

Compliance testing is a critical part of the design cycle in order to ensure that requirements are met. The QualiPHY framework provides an automated and easy-to-use compliance testing platform for a number of serial data standards.



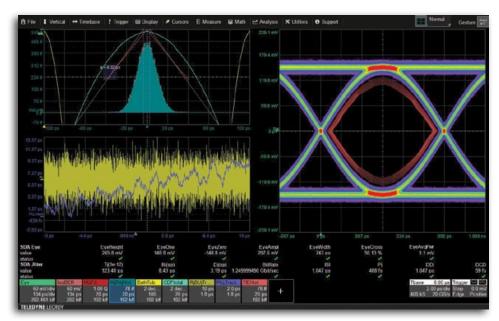


;	WaveRunner 8000 Serial Data Protocol Support	Trigger	Decode	Measure/Grant	Eye Diagram	Protosync	QualipHy
	I <sup>2</sup> C	•	•	•	•		
Embedded Computing	SPI	•	•	•	•		
ombe	UART-RS232	•	•	•	•		
	USB2-HSIC		•				
	CAN	•	•	•	•		
strial	CAN FD	•	•	•	•		
inpu	FlexRay	•	•	•	•		
- +	LIN	•	•	•	•		
moti	SENT		•				
Automotive + Industrial	MOST50/150						•
Ì	BroadR-Reach						•
တ္	ARINC429		•	•	•		
Avionics	MIL-STD-1553	•	•	•	•		
Ā	SPACEWIRE		•				
	Ethernet (10/100Base-T)		•				•
ting, als	Ethernet (1000Base-T)						•
nput	USB 2.0	•	•	•	•	•	•
d Col	8b/10b	•	•		•		
Spee	Fibre Channel		•				
High Speed Computing Storage +Peripherals	SATA (1.5 & 3 Gb/s)	•	•			•	
	SAS (1.5 & 3 Gb/s)		•			•	
	PCI Express (Gen1)		•			•	
2	LPDDR2				•		•
Memory	DDR2				•		•
Σ	DDR3				•		•
	D-PHY/CSI-2/DSI		•		•		•
	DigRF3G		•	•			
M	DigRFv4		•	•			
_	UniPro		•				
Ì	M-PHY		•		•		
_	Audio (I <sup>2</sup> S, LJ, RJ, TDM)	•	•	•			
Other	Manchester		•				
	NRZ	•	•		•		

# MOST COMPLETE SERIAL DATA DEBUG AND VALIDATION

# SDA II – Advanced Tools to Isolate and Analyze (WR8K-SDAII)

Unleash the power of serial data analysis for understanding and characterizing a design, proving compliance, and understanding why a device or host fails compliance. The SDAII architecture provides fast updates and eye diagram creation. Combined with up to 128 Mpts record lengths and more complete jitter decomposition tools, SDA II provides a fast and complete understanding of why serial data fails a compliance test. Whether debugging eye pattern or other compliance test failures, the WaveRunner 8000 Oscilloscopes rapidly isolate the source of the problem.



Advanced jitter decomposition methodologies and tools provide more information about root cause. Tj Analysis, RjBUj Analysis and DDj Analysis are made simple with the deepest toolset dedicated to providing the highest level of insight into your serial data signals.

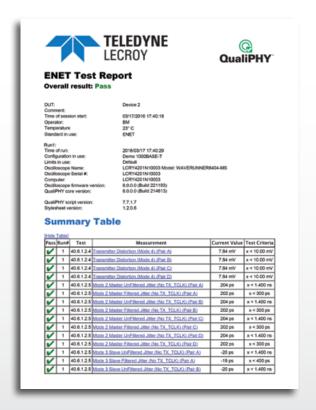
# **QualiPHY**

QualiPHY is designed to reduce the time, effort, and specialized knowledge needed to perform compliance testing on high-speed serial buses.

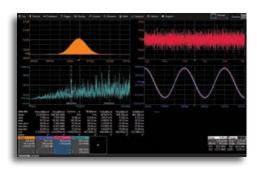
- Guides the user through each test setup
- Performs each measurement in accordance with the relevant test procedure
- Compares each measured value with the applicable specification limits
- Fully documents all results
- QualiPHY helps the user perform testing the right way every time

# **Supported Standards:**

- ENET
- USB
- DDR2, DDR3, LPDDR2
- MIPI-DPHY
- BroadR-Reach
- MOST50, MOST150

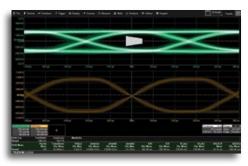


Compliance Reports contain all of the tested values, the specific test limits and screen captures. Compliance Reports can be created as HTML, PDF or XML.



# **Jitter and Timing Analysis** Option (WR8K-JITKIT)

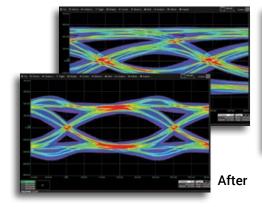
JITKIT makes it simple and easy to understand the basic system jitter performance of clock signals and clock-data activities, including period, half period, cycle-cycle, skew, amplitude, differential voltage crossing, slew rate, and a wide variety of other common jitter measurements.



# **DDR Debug Toolkit** (WR8K-DDR3-Toolkit)

The DDR Debug Toolkit provides test, debug and analysis tools for the entire DDR design cycle. The unique DDR analysis capabilities provide automatic Read and Write burst separation, bursted data jitter analysis and DDR-specific measurement parameters. The WaveRunner 8000 supports both standard and custom speed grades of DDR2 and DDR3.

# **Before**



# **Eye Doctor II** (WR8K-EYEDRII)

The Eye Doctor II advanced signal integrity toolkit enables a complete set of channel emulation, de-embedding, and receiver equalization simulation tools. It provides capability to emulate a serial data link, de-embed or embed a fixture, cable or serial data channel. add or remove emphasis, and perform CTLE, FFE, or DFE equalization.



# Q-Scape Multi-tab Display **Architecture (WR8K-Q-SCAPE)**

Unique Q-Scape multitab display architecture speeds up your understanding of your design with 4x the display area. Acquired or calculated waveforms can be located on any of four different "tabbed" oscilloscope grid displays, with individually selectable grid styles available for each tab. Quickly move waveforms to different tabs through drag-and-drop.

### **Advanced Probe Interface**

The advanced active probe interface gives tremendous flexibility for measuring high voltages, high frequencies, currents, or differential signals.

# **High Impedance Active Probes**



**High Bandwidth Differential Probes** 



**High Voltage Differential Probes** 



**High Voltage Passive Probes** 



# **Current Probes**



# **ADDITIONAL APPLICATIONS AND CUSTOMIZATION**



Use two independent input settings and frequency ranges for advanced spectrum analysis.

# Spectrum Analyzer Option (WR8K-SPECTRUM)

The Spectrum Analyzer mode provides a spectrum analyzer style user interface with controls for start/stop frequency or center frequency and span. The resolution bandwidth is automatically set for best analysis or can be manually selected. Vertical Scale can be selected in the desired units and the unique peak search automatically labels spectral components and presents frequency and level in an interactive table. To monitor how the spectrum changes over time, view the spectrogram which can display a 2D or 3D history of the frequency content.



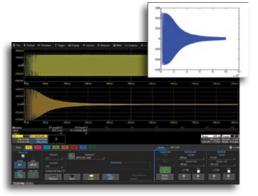
# Power Analyzer Software Option (WR8K-PWR)

Quickly measure and analyze operating characteristics of power conversion circuits. Make automatic switching device measurements and identify areas of loss and conduction with color-coded overlay. Control loop modulation analysis and line power harmonic testing are all simplified with a dedicated user interface.



# Digital Filter Software Option (WR8K-DFP2)

DFP2 lets you implement Finite Impulse Response (FIR) or Infinite Impulse Response (IIR) filters to eliminate undesired spectral components, such as noise, and enhances your ability to examine important signal components. You can choose from a standard set of FIR or IIR filters or you can also design your own custom filters. Create and apply a variety of FIR and IIR digital filters to your capture waveforms or processed traces.



# **XDEV Advanced Customization Option (WR8K-XDEV)**

With the XDEV option, third party programs can be completely integrated into the oscilloscope's processing stream. Create customized math functions and parameters using C/C++, MATLAB, Excel, JScript or Visual Basic without ever leaving the oscilloscope application - and view the results directly on the oscilloscope, in real-time.

# **WAVERUNNER 8000-R LOW-PROFILE OSCILLOSCOPE**

# **Key Features**

Low-profile design - <2U (3.5")

1, 2.5, and 4 GHz bandwidths

Up to 40 GS/s sample rate

Deep Memory - up to 128 Mpts

Fully software-compatible with the WaveRunner 8000

Remote connectivity via LXI, USBTMC, and LAN

Rackmount kit and removable SSD standard

Same powerful, deep toolbox of WaveRunner 8000 oscilloscopes

Support for ProBus active probes



WaveRunner 8000-R oscilloscopes utilize the WaveRunner 8000 acquisition system to provide a high-performance, 4 GHz oscilloscope in a convenient, low-profile form factor.

# **Low-Profile Form Factor**

The WaveRunner 8000-R models provide a convenient form factor for a 4 GHz oscilloscope. The compact design has a height of less than 2U (3.5", 8.89 cm) and includes a standard rackmount kit, easily lending itself to be installed in an automated test environment.

# **Powerful, Deep Toolbox**

Unlike most digitizing systems the WaveRunner 8000-R provides the powerful, deep toolbox that is expected in a Teledyne LeCroy oscilloscope. The full range of the WaveRunner 8000's analysis capability is available; including an array of serial protocol analysis packages and application specific packages.

# **Easily Transition Test Programs**

The WaveRunner 8000-R models are fully software-compatible with their WaveRunner 8000 counterparts. Development can be conducted with the assistance of the front panel and display of the WaveRunner 8000 and then seamlessly transitioned to automated testing.

# **Flexible Connectivity Options**

A variety of remote connectivity options (LXI, USBTMC, and LAN) offer flexibility when connecting to the WaveRunner 8000-R. Teledyne LeCroy's free WaveStudio software is a fast and easy way to analyze acquired waveforms off-line, or remotely control an oscilloscope from your desktop.

	WaveRunner 8054	WaveRunner 8104/ 8104-R	WaveRunner 8254/ 8254M/8254M-R	WaveRunner 8404/ 8404M/8404M-R			
Vertical System							
Analog Bandwidth @ 50 Ω (-3 dB)	500 MHz (≥ 2 mV/div)	1 GHz (≥ 2 mV/div)	2.5 GHz (≥ 5 mV/div)	4 GHz (≥ 5 mV/div)			
Analog Bandwidth @ 1 M $\Omega$ (-3 dB)	500 MHz (typical)	500 MHz (typical)	500 MHz (typical)	500 MHz (typical)			
Rise Time (10-90%, 50 Ω)	700 ps (typical)	415 ps (typical)	160 ps (typical)	100 ps (typical)			
Rise Time (20-80%, 50 Ω)	480 ps (typical)	290 ps (typical)	120 ps (typical)	75 ps (typical)			
Input Channels	4	(4)	(7)	(-)/I/			
Bandwidth Limiters	20 MHz, 200 MHz	20 MHz, 200 MHz	20 MHz, 200 MHz, 1 GHz	20 MHz, 200 MHz, 1 GHz			
Input Impedance	50 $\Omega$ ±2% or 1 M $\Omega$    17pF, 10 M $\Omega$    9.5 pF with supplied Probe						
Input Coupling	1 MΩ: AC, DC, GND; 50 Ω: DC, GND						
Maximum Input Voltage		$\Omega$ : 400 V max. (DC + peak AC <					
Channel-Channel Isolation		ted BW (typical)	DC -2.5 GHz: >100:1; 2.5 GH	z to rated BW: >30:1 (typical)			
Vertical Resolution	8-bits; up to 11-bits with enh						
Sensitivity	<b>50</b> Ω: 1 mV/div-1 V/div, fully		) V/div, fully variable				
DC Vertical Gain Accuracy (Gain Component of DC Accuracy)	±1% F.S. (typical), offset at 0	V					
Offset Range	50	Ω:		) Ω:			
	±1.6 V @ 1 mV – 4.95 mV/d	iv, ±4 V @ 5 mV-9.9 mV/div,		1 GHz			
		iv, ±10 V @ 20 mV−1 V/div <b>Λ</b> Ω:	±1.6 V @ 1 mV-4.95 mV/di	iv, ±4 V @ 5 mV-9.9 mV/div,			
	±1.6 V @ 1 mV-4.95 mV/di	v, ±4 V @ 5 mV-9.9 mV/div,		div, ±10 √ @ 20 mV−1 V/div • <b>1 GHz</b>			
	±8 V @ 10 mV-19.8 mV/div,	±16 V @ 20 mV-100 mV/div,		iv, ±10 V @ 102 mV-1 V/div			
	±80 V @ 102111V-1.0 V/div	, ±160 V @ 1.02 V−10 V/div		<b>MΩ:</b> iv, ±4 V @ 5 mV−9.9 mV/div,			
			±8 V @ 10 mV-19.8 mV/div,	±16 V @ 20 mV-140 mV/div, ±16 V @ 1.42 V-10 V/div			
DC Vertical Offset Accuracy	±(1.5% of offset setting +1%	of full scale + 1 mV) (test limi		7, ±100 V (@ 1.42 V 10 V/GIV			
Horizontal System	=(g *	or rail oddie v r rivy (cost iii ii	,				
Timebases	Internal timehase common t	o 4 input channels: an extern	al clock may be applied at the	EYT input			
Time/Division Range	20 ps/div - 1.6 ks/div with sta		ai clock may be applied at the	EXT IIIput			
Time, Division Hange	M Models: 20 ps/div - 6.4 ks	s/div with standard memory					
	RIS available at ≤ 10 ns/div;						
Clock Accuracy	Roll Mode available at ≥ 100			<u> </u>			
Clock Accuracy Trigger and Interpolator Jitter	≤ 1.5 ppm +(aging of 0.5 ppn		, 2 F 22	. 7			
rrigger and interpolator sitter	≤ 4 ps <sub>rms</sub> (typical)	≤ 3.5 ps <sub>rms</sub> (typical)	≤ 2.5 ps <sub>rms</sub> (typical)	≤ 2 ps <sub>rms</sub> (typical)			
	< 0.1 ps <sub>rms</sub>	< 0.1 ps <sub>rms</sub>	< 0.1 ps <sub>rms</sub>	< 0.1 ps <sub>rms</sub>			
	(typical, software assisted)	(typical, software assisted)	(typical, software assisted)	(typical, software assisted)			
Channel-Channel Deskew Range	±9 x time/div. setting, each c	hannel					
External Timebase Reference (Input)	10 MHz ±25 ppm						
External Timebase Reference (Output)			g used by user (internal or ext	ernal reference)			
External Clock	DC to 100 MHz; (50 $\Omega$ /1 M $\Omega$ ) Minimum rise time and amp	), Ext. BNC input, litude requirements apply at l	ow frequencies				
		medde regamerriente appry acr	on nequenoise				
Acquisition System							
Single-Shot Sample Rate/Ch	10 GS/s on 4 Ch	; 20 GS/s on 2 Ch		; 20 GS/s on 2 Ch			
Random Interleaved Sampling (RIS)	200 CC/a for repetitive signs	la (20 na /div ta 10 na /div)	M Models: 20 GS/s or	n 4 Ch; 40 GS/s on 2 Ch			
	200 GS/s for repetitive signa 1,000,000 waveforms/secon		Labannala)				
Maximum Trigger Rate Intersegment Time	1,000,000 waveforms/secon	ia (iii Sequence Mode, up to 4	+ CHAITHEIS)				
Standard Memory (4 Ch / 2 Ch / 1 Ch)		32M (5,000)	1614 / 3214	/ 32M (5,000)			
(Number of Segments)	101017 321017	32101 (0,000)		28M / 128M (15,000)			
(Number of degiments)				( 2,5 5 2)			
Acquisition Processing							
Averaging	Summed averaging to 1 milli		aging to 1 million sweeps				
Enhanced Resolution (ERES)	From 8.5- to 11-bits vertical r						
Envelope (Extrema)	Envelope, floor, or roof for up						
Interpolation	Linear or Sin x/x (2 pt and 5 pt	ot)					
Digital - Vertical and Acquisition (	(-MS Models Only)						
Input Channels	16 Digital Channels			_			
Threshold Groupings	Pod 2: D15 - D8, Pod 1: D7 - [	00					
Threshold Selections	TTL, ECL, CMOS (2.5 V, 3.3 V,		ined				
Maximum Input Voltage	±30V Peak						
Threshold Accuracy	$\pm$ (3% of threshold setting + 1	00mV)					

	WaveRunner 8054	WaveRunner 8104/ 8104-R	WaveRunner 8254/ 8254M/8254M-R	WaveRunner 8404/ 8404M/8404M-R
<b>Digital - Vertical and Acquisition</b>		1		
Input Dynamic Range	± 20V			
Minimum Input Voltage Swing	400mV			
Input Impedance (Flying Leads)  Maximum Input Frequency	100 kΩ    5 pF 250 MHz			
Sample Rate	1.25 GS/s			
Record Length	32MS - 16	Channels	32MS - 16	Channels
ricoord Lerigin	021110 10	onamicio		MS - 16 Channels
Minimum Detectable Pulse Width	2 ns			
Channel-to-Channel Skew	350 ps			
User Defined Threshold Range	±10 V in 20 mV steps			
User Defined Hysteresis Range	100 mV to 1.4 V in 100 mV ste	ps		
Triggering System				
Modes	Normal, Auto, Single, and Sto	р		
Sources		D, or line; slope and level unic	que to each source (except line	e trigger)
Coupling Mode	DC, AC, HFRej, LFRej			
Pre-trigger Delay	0 - 100% of memory size (ad			
Post-trigger Delay			me/div settings or in roll mode	9
Hold-off by Time or Events Internal Trigger Range	From 2 ns up to 20 s or from ±4.1 div from center (typical)	1 to 99,999,999 events		
Trigger Sensitivity with Edge Trigger	2 div @ < 500 MHz	2 div @ < 1 GHz	2 div @ < 2.5 GHz	2 div @ < 4 GHz
(Ch 1-4)	1.5 div @ < 250 MHz	1.5 div @ < 500 MHz	1.5 div @ < 1.25 GHz	1.5 div @ < 2 GHz
,	1 div @ < 200 MHz	1 div @ < 200 MHz	1 div @ < 200 MHz	1 div @ < 200 MHz
	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz	0.9 div @ < 10 MHz
	(DC, AC, and LFRej coupling)	(DC, AC, and LFRej coupling)	(DC, AC, and LFRei coupling)	(DC, AC, and LFRei coupling)
External Trigger Sensitivity,	2 div @ 1 GHz	Er riej oodpiirig)	Er riej oodpiirig)	Li riej ocapinig)
(Edge Trigger)	1.5 div @ < 500 MHz			
	1 div @ < 200 MHz			
	0.9 div @ < 10 MHz			
Max. Trigger Frequency,	(DC, AC, and LFRej coupling) 500 MHz @ ≥	1.0 GHz @ ≥	2.0 GHz @ ≥	2.0 GHz @ ≥
SMART Trigger  SMART Trigger	10 mV/div 1.2 ns	1.0 GHZ @ ≥ 10 mV/div	2.0 GH2 @ ≥ 10 mV/div	2.0 GH2 @ ≥ 10 mV/div
OWN THE THINGS	(minimum triggerable	(minimum triggerable	(minimum triggerable	(minimum triggerable
Estamol Trianna Innat Dana	width 1.2 ns)	width 750 ps)	width 300 ps)	width 200 ps)
External Trigger Input Range	Ext (±0.4 V); Ext/10 (±4 V)			
<b>Basic Triggers</b>				
Edge	Triggers when signal meets s	slope (positive, negative, or ei	ither) and level condition	
Window	Triggers when signal exits a	window defined by adjustable	e thresholds	
TV-Composite Video	Triggers NTSC or PAL with se HDTV (720p, 1080i, 1080p) w CUSTOM with selectable Fiel Interlacing (1:1, 2:1, 4:1, 8:1),	with selectable frame rate (50 ds $(1-8)$ Lines (up to 2000)	Frame Bates (25, 30, 50, or 6)	0 Hz),
SMART Triggers				
State or Edge Qualified	Triggers on any input source	only if a defined state or edg	e occurred on another input s	ource.
	Delay between sources is sel	ectáble by time or events	· · · · · · · · · · · · · · · · · · ·	
Qualified First	In Sequence acquisition mod	e, triggers repeatably on eve	nt B only if a defined pattern, s etween sources is selectable b	state, or edge (event A) is
Dropout	Triggers if signal drops out for			by time or events
Pattern			channels and external trigger in	nnut. Fach source can be
- attern	high, low, or don't care. The H	ligh and Low level can be sel	ected independently. Triggers	at start or end of the pattern
SMART Triggers with Exclusion		vo alitoboo with withless - 1	ctable as low as 200 ps (deper	oding on ocalilara and barrier
Glitch	width) to 20 s, or on intermitt		ctable as low as 200 ps (deper	nding on oscilloscope band-
Width (Signal or Pattern)		ve glitches with widths selec	ctable as low as 500 ps (deper	nding on oscilloscope band-
Interval (Signal or Pattern)	Triggers on intervals selectal			
Timeout (State/Edge Qualified)	Triggers on any source if a gi Delay between sources is 1 n		) has occurred on another sou	irce.
Runt	Trigger on positive or negative	e runts defined by two voltac		
	Select between 1 ns and 20 r	ns		
Slew Rate			elect edge limits between 1 ns	
Exclusion Triggering	rrigger on intermittent faults	by specifying the expected by	pehavior and triggering when t	that condition is not met
Measurement Trigger				
	Trigger on measurement valu	ues, Edge, Serial Pattern, Bus	Pattern, Non-monotonic	
	33	J		

	WaveRunner 8054	WaveRunner 8104/ 8104-R	WaveRunner 8254/ 8254M/8254M-R	WaveRunner 8404/ 8404M/8404M-R			
Cascade (Sequence) Triggering							
Capability	Arm on "A" event, then Trigger on "B" event. Or Arm on "A" event, then Qualify on "B" event, and Trigger on "C" event.  Cascade A then B: Edge, Window, Pattern (Logic) Width, Glitch, Interval, Dropout, or Measurement. Measurement can be o						
Types	Cascade A then B: Edge, Windo Stage B only.	ow, Pattern (Logic) Width, Glitch,	Interval, Dropout, or Measurer	ment. Measurement can be on			
	rn (Logic), Width, Glitch, Interva , or Measurement. Measurem						
Holdoff	Holdoff between A and B, B and C, C and D is selectable by time (1ns to 20s) or number of events. Measurement trigger selection as the last stage in a Cascade precludes a holdoff setting between the prior stage and the last stage.						
Optional High-speed Serial Proto	ocol Triggering (WR8K-80B	-8B10B TD)					
Data Rates	150 Mb/s-3.125 Gb/s						
Pattern Length	80-bits, NRZ or 8b/10b						
Clock Recovery Jitter	1 ps <sub>rms</sub> + 0.3% Unit Interval F	RMS for PRBS data patterns wit	th 50% transition density				
Hardware Clock Recovery Loop BW		100 Mb/s to 2.488 Gb/s (typic					
Color Waveform Display		.,	- ,				
Type	Color 12.1" widescreen flat pa	anel TFT-Active Matrix with hig	h resolution touch screen (n	ot included on R Models)			
Resolution	WXGA; 1280 x 800 pixels						
Number of Traces	Display a maximum of 16 tra	ces. Simultaneously display ch	nannel, zoom, memory and n	nath traces			
Grid Styles	Auto, Single, Dual, Quad, Octa	al, X-Y, Single+X-Y, Dual+X-Y, Tai	ndem, Quatro, Twelve, Sixtee	en			
Waveform Representation	Sample dots joined, or sample	le dots only					
Processor/CPU		•					
Type	Intel® i5-3610 Dual Core, 2.7	GHz (or better), R Models: Inte	l® Celeron, 1.4 GHz (or bette	er)			
Processor Memory	8 GB standard, up to 16 GB o M Models: 16 GB standard, F						
Operating System	Microsoft Windows® 7 Profe	ssional for Embedded Systems rs® 7 Professional Edition (64-b	s, 64-bit; oit)				
Real Time Clock		waveform in hardcopy files. SN		precision internal clocks			
Interface							
Remote Control	Via Windows Automation or	via Teledyne LeCroy Remote C	ommand Set				
Network Communication Standard	VXI-11 or VICP, LXI Class C (v		orminaria det				
GPIB Port (Optional)	Supports IEEE-488.2 (Extern			_			
Ethernet Port		T Ethernet interface (RJ45 por	t) R Models: includes 2 nort	ts			
USB	4 side USB 3.1 Gen1 ports, 2	side USB 2.0 ports, and 1 front a1 ports, 2 rear USB 2.0 ports a	: USB 2.0 port support Windo	ows compatible devices			
USB Device Port		1 Gen1, R Models: USBMTMC					
External Monitor Port	2 full-size Display Port conne Includes support for extende	ctors and 1 DVI-D. <b>R Models:</b> 1 d desktop operation with WXG.	full-size Display Port conne A resolution on second mon	ctors and 1 VGA itor			
Power Requirements							
Voltage	100-240 VAC ±10% at 50/60	) Hz ±5%; 100-120 VAC ±10%	at 400 Hz ±5%:				
Power Consumption (Nominal)	Automatic AC Voltage Select			40 W / 340 VA			
Max Power Consumption		500 W / 500 VA, <b>R Models</b> : 320					
Max r over condumption	with all PC peripherals, active	e probes connected to 4 channel	els, and MSO active	20 11 / 120 111			
Environmental							
Temperature (Operating)	+5 °C to +40 °C						
Temperature (Non-Operating)	−20 °C to +60 °C						
Humidity (Operating)	5% to 90% relative humidity ( Upper limit derates to 50% re	non-condensing) up to +31 °C lative humidity (Non-condensin	ng) at +40 °C				
Humidity (Non-Operating)		non-condensing) as tested per					
Altitude (Operating)	Up to 3,000 m at or below +3	0 °C					
Random Vibration (Operating)	0.31 g <sub>rms</sub> 5 Hz to 500 Hz, 15	minutes in each of three orthog	gonal axes				
Random Vibration (Non-Operating)		ninutes in each of three orthogo					
Functional Shock		3 shocks (positive and negative)		es, 18 shocks total			
Physical Dimensions							
Dimensions (HWD)	12.44" H x 16.42" W x 9.37" D	(316 x 417 x 238 mm), R Mod	els: 3.41" x 17.52" x 17.52" (	86.5 x 445 x 445 mm)			
Weight	22.8 lbs. (10.3 kg), R Models:			,			
Certifications		\ =/					
OCI (III) CALIFORNIA	CE Compliant III and all lie	ted; Conforms to UL 61010-1 (	3rd Edition) III 61010-2 020	n (1st Edition)			
	CAN/CSA C22.2 No. 61010-1		ora Eartion), OE 01010-2-030	o (13t LuitiOH)			
Warranty and Service							
	3-year warranty; calibration rupgrades, and calibration ser	ecommended annually. Option vices	al service programs include	extended warranty,			

### **Standard**

### **Math Tools**

Display up to 8 math function traces (F1-F8). The easy-to-use graphical interface simplifies setup of up to two operations on each function trace, and function traces can be chained together to perform math-on-math.

absolute value exp (base 10) product (x) average (summed) fft (power spectrum, reciprocal power average, average (continuous) rescale (with units) magnitude, phase, correlation roof up to 128 Mpts) (two waveforms) (sinx)/x floor derivative sparse integral deskew (resample) square interpolate (cubic, difference (-) quadratic, sinx/x) square root enhanced resolution sum (+) invert (negate) (to 11 bits vertical) log (base e) zoom (identity) envelope log (base 10) exp (base e)

### **Measure Tools**

Display any 8 parameters together with statistics, including their average, high, low, and standard deviations. Histicons provide a fast, dynamic view of parameters and wave shape characteristics. Parameter Math allows addition, subtraction, multiplication, or division of two different parameters.

amplitude	level @ x	rms
area	maximum	std. deviation
base	mean	top
bit rate	median	width
cycles	minimum	phase
delay	narrow band phase	time @ minimum (min.)
$\Delta$ delay	narrow band power	time @ maximum (max.)
duty cycle	number of points	$\Delta$ time @ level
duration	+ overshoot	$\Delta$ time @ level from
falltime (90–10%,	- overshoot	trigger
80-20%, @ level)	peak-to-peak	x @ max.
frequency	period	x @ min.
first	risetime (10-90%,	
last	20-80%, @ level)	

### Pass/Fail Testing

Simultaneously test multiple parameters against selectable parameter limits or pre-defined masks. Pass or fail conditions can initiate actions including document to local or networked files, e-mail the image of the failure, save waveforms, send a pulse out at the front panel auxiliary BNC output, or (with the GPIB option) send a GPIB SRQ.

### Standard (cont'd)

### **Basic Jitter and Timing Analysis**

This package provides jitter timing and analysis using time, frequency, and statistical views for common timing parameters, and also includes other useful tools. Includes:

- "Track" graphs of all parameters, no limitation of number
- N-Cycle
  Edge to Edge
  Frequency @ level
  Period @ level
  Half Period
  Width @ level
  Time Interval
  Duty Cycle @ level
  Duty Cycle Error
  Duty Cycle Error
  Puty Cycle Error
  Duty Cycle Error
  Duty Cycle Error
  Duty Cycle Error
- Edge @ Iv parameter (counts edges)
- Histograms expanded with 19 histogram parameters and up to 2 billion events
- Trend (datalog) of up to 1 million events
- Persistence histogram, persistence trace (mean, range, sigma)

### **Software Options**

# Advanced Customization (WR8K-XDEV)

Provides capability to create a math function or measurement parameter in MATLAB, Excel, C++, JavaScript, or Visual Basic Script (VBS) format and insert it into the oscilloscope's processing stream. All results are processed and displayed on the oscilloscope grid, and are available for further processing. Also permits the creation of customized plug-ins that can be inserted into the scope user interface, control of the scope via Visual Basic scripts embedded in customized functions, and use of Teledyne LeCroy's Custom DSO capabilities.

### SDA II Serial Data Analysis Option (WR8K-SDAII)

### Total Jitter

A complete toolset is provided to measure total jitter. Eye Diagrams with millions of UI are quickly calculated from up to 128 Mpts records, and advanced tools may be used on the Eye Diagram to aid analysis. Complete TIE and Total Jitter (Tj) parameters and analysis functions are provided.

- Time Interval Error (TIE) Measurement Parameter, Histogram, Spectrum and Jitter Track
- Total Jitter (Tj) Measurement Parameter, Histogram, Spectrum
- Eye Diagram Display (sliced)
- Eye Diagram IsoBER (lines of constant Bit Error Rate)
- · Eye Diagram Mask Violation Locator
- Eye Diagram Measurement Parameters
- Eye Height
   Dne Level
   Eye Crossing
   Mask out
   Zero Level
   Eye Power
   Eye Amplitude
   Extinction Ratio
   Slice Width (setting)
- Q-Fit Tail Representation
- Bathtub Curve
- Cumulative Density Function (CDF)
- PLL Track

### **Software Options (cont'd)**

### SDA II Serial Data Analysis Option (WR8K-SDAII) - continued

### Jitter Decomposition Models

Two jitter decomposition methods are provided and simultaneously calculated to provide maximum measurement confidence. Q-Scale, CDF, Bathtub Curve, and all jitter decomposition measurement parameters can be displayed using either method.

- Spectral Method
- NQ-Scale Method

### Random Jitter (Rj) and Non-Data Dependent Jitter (Rj+BUj)

- Random Jitter (Rj) Measurement Parameter
- Ri+BUi Histogram
- Rj+BUj Spectrum
- Rj+BUj Track

### Deterministic Jitter (Dj)

• Deterministic Jitter (Dj) Measurement Parameter

### Data Dependent Jitter (DDj)

- Data Dependent Jitter (DDj) Measurement Parameter
- DDj Histogram
- DDj Plot (by Pattern or N-bit Sequence)

### Eye Doctor II Advanced Signal Integrity Tools (WR8K-EYEDRII)

Complete set of channel emulation, de-embedding and receiver equalization simulation tools. Provides capability to emulate a serial data link, de-embed or embed a fixture, cable or serial data channel, add or remove emphasis, and perform CTLE, FFE, or DFE equalization.

### Power Analyzer Option (WR8K-PWR)

Power switching device measurements, control loop modulation analysis, and line power harmonic testing are all simplified with a dedicated user interface and automatic measurements.

### Device Analysis

- Losses Automatic measurement of turn-on, turn-off, and conduction loses as well as off-state power, total losses and switching frequency
- Safe Operating Area
- B-H-Hysteresis Curve
- Dynamic On-Resistance
- Dv/dt and di/vt

### Control Loop Analysis

Closed loop time-domain – Duty cycle, width, period or frequency

### Line Power Analysis

- Power Vrms, Irms, real-power, apparent power, power factor, crest factor
- Harmonics EN61000-3-2 pre-compliance, Total Harmonic Distortion

### Measurement Setup

• Controls for Deskew, DC fine adjust, probe integration, device zone identification

### Cable De-embedding Option (WR8K-CBL-DE-EMBED)

Removes cable effects from your measurements. Simply enter the S-parameters or attenuation data of the cable(s) then all of the functionality of the WR8K can be utilized with cable effects de-embedded.

# 8b/10b Decode and 80-bit High Speed Serial Trigger Option (WR8K-80B-8B10B TD)

Intuitive, color-coded serial trigger decode with powerful search capability enables captured waveforms to be searched for user-defined sequences of symbols. Multi-lane analysis decodes up to four simultaneously captured lanes. Includes 150 Mb/s to 3.125 Gb/s High-speed 80-bit Serial Pattern Trigger Option

### **Software Options (cont'd)**

### Serial Data Mask Option (WR8K-SDM)

Create eye diagrams using a comprehensive list of standard eye pattern masks, or create a user-defined mask. Mask violations are clearly marked on the display for easy analysis.

### Electrical Telecom Pulse Mask Test Option (WR8K-ET-PMT)

Performs automated compliance mask tests on a wide range of electrical telecom standards.

### Spectrum Analyzer Option (WR8K-SPECTRUM)

Spectrum analyzer style user interface and advanced FFT capabilities.

- Automatic oscilloscope setup when selecting start/stop frequency or center frequency and span
- · Resolution bandwidth automatically or manually controlled
- FFT Reference and vertical scale in dBm, dBV, dBmV, dBuV, Vrms or Arms
- Spectrogram provides 2D or 3D spectral history display
- Up to 100 automatic peak markers
- Up to 20 markers, either manually controlled or automatic which mark fundamental frequency and harmonics
- Math waveform analysis, additional output types:
- Power density
- Real
- Imaginary
- Magnitude squared

### Disk Drive Measurements Option (WR8K-DDM2)

This package provides disk drive parameter measurements and related mathematical functions for performing disk drive WaveShape Analysis.

- Disk Drive Parameters are as follows:
- amplitude asymetry
- local base
- local baseline separation
- local maximum
- local minimum
- local number
- local peak-peak
- local time
- between events
   local time
- between peaks

   local time
- local time
   between troughs

- local time at minimum
- local time
   at maximum
- local time peak-trough
- local time
   over threshold
- local time
- trough-peak

   local time
  under threshold
- narrow band phase
- narrow band power

- overwrite
- pulse width 50
- pulse width 50 -
- pulse width 50 +
- resolution
- track average amplitude
- track average amplitude –
- track average amplitude +
- auto-correlation s/n
- non-linear transition shift

# ORDERING INFORMATION

Product Description	Product Code
WaveRunner 8000 Oscilloscopes	
500 MHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8054
Oscilloscope with 12.1"" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
1 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8104
Oscilloscope with 12.1"" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
2.5 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8254
Oscilloscope with 12.1"" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
4 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8404
Oscilloscope with 12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
2.5 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8254M
Oscilloscope with 12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode.	
4 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8404M
Oscilloscope with 12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode.	
500 MHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8054-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
1 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8104-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	
2.5 GHz, 10 GS/s, 4ch, 16 Mpts/Ch	WaveRunner 8254-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode	
4 GHz, 10 GS/s, 4ch, 16 Mpts/Ch Mixed	WaveRunner 8404-MS
Signal Oscilloscope with	
12.1" WXGA Color Display.	
32 Mpts/Ch in interleaved mode.	W
2.5 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8254M-MS
Mixed Signal Oscilloscope with	
12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode. 4 GHz, 20 GS/s, 4ch, 64 Mpts/Ch	WaveRunner 8404M-MS
	vvavenuiiiei 8404M-MS
Mixed Signal Oscilloscope with 12.1" WXGA Color Display.	
128 Mpts/Ch in interleaved mode.	

# Included with Standard Configurations (WaveRunner 8000 and WaveRunner 8000-MS)

÷10, 500 MHz Passive Probe (Qty. 4), Protective Cover, Getting Started Guide, Anti-virus Software (Trial Version), Microsoft Windows® 7 for Embedded Systems 64-bit License, Commercial NIST Traceable Calibration with Certificate, Power Cable for the Destination Country, 3-year Warranty

# **Included with WaveRunner 8000-MS**

16 Channel Digital Leadset, Extra Large Gripper Probe Set (Qty. 22), Ground Extenders (Qty. 20), Flexible Ground Leads (Qty. 5)

# **Computer Upgrade**

oompater opgrade	
256 GB Removable Solid State Drive Option	WR8K-256GB-RSSD
Additional 256 GB Solid State Drive for use	WR8K-256GB-RSD-02
with RSSD option. Includes Windows 7 Pro for	
Embedded Systems OS, LeCroy Oscilloscope	
Software and Critical Scope Operational	
File Duplicates.	
Upgrade from 8 GB RAM to 16 GB RAM	WR8K-UPG-16GBRAM

# Product Description Product Code

# **WaveRunner 8000-R Oscilloscopes**

1 GHz, 10 GS/s, 4ch, 16 Mpts/Ch,	WaveRunner 8104-R
2U form factor Oscilloscope.	
20 GS/s, 32 Mpts/Ch in interleaved mode.	
2.5 GHz, 20 GS/s, 4ch, 64 Mpts/Ch,	WaveRunner 8254M-R
2U form factor Oscilloscope.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	
4 GHz, 20 GS/s, 4ch, 64 Mpts/Ch,	WaveRunner 8404M-R
2U form factor Oscilloscope.	
40 GS/s, 128 Mpts/Ch in interleaved mode.	

# **Included with Standard Configurations**

 $\div 10,500$  MHz Passive Probe (Qty. 4), Getting Started Guide, Rackmount kit, Removable SSD, Anti-virus Software (Trial Version), Microsoft Microsoft Windows® 7 Professional Edition (64-bit), Commercial NIST Traceable Calibration with Certificate, Power Cable for the Destination Country, 3-year Warranty

# ORDERING INFORMATION

Product Description	Product Code	Product Description	Product Code
Serial Trigger and Decode		Serial Trigger and Decode	
MIL-STD-1553 Trigger and Decode Option	WR8K-1553 TD	MIPI UniPro Protocol Decoder Software Option	WR8K-UNIPRObus D
MIL-STD-1553 Trigger, Decode, Measure/	WR8K-1553 TDME		K-UPG-MPHY-UNIPRObus D
Graph, and Eye Diagram Option		Software Upgrade	
8b10b Decode Option- Includes 80 bit	WR8K-80B-8b10b TD	MPHY REQUIRED	
3.125 Gb/s serial trigger		USB 2.0 HSIC Decode Option	WR8K-USB2-HSICbus D
AudioBus Trigger and Decode Option	WR8K-Audiobus TD	USB2 Trigger and Decode Option	WR8K-USB2bus TD
AudioBus trigger, decode, and graph Option	WR8K-Audiobus TDG	USB 2.0 Trigger and Decode Option	WR8K-USB2BUS TD
	NC429BUS DSYMBOLIC	USB 2.0 Trigger, Decode, Measure/	WR8K-USB2BUS TDME
Decode Option  ARINC 429 Bus Symbolic WR8K-ARINC4	429BUS DME SYMBOLIC	Graph, and Eye Diagram Option	
Decode, Measure/Graph,	+29BO2 DIVIE 21MBOLIC	Carial Bata Carrellianas	
and Eye Diagram Option		Serial Data Compliance QualiPHY Enabled BroadR-Reach	ODLIV DrandD Danah
CAN FD Trigger and Decode Option	WR8K-CAN FDBUS TD	Software Option	QPHY-BroadR-Reach
	/R8K-CAN FDBUS TDME	QualiPHY Enabled Ethernet 10/100/1000BT	QPHY-ENET*
Graph, and Eye Diagram Option		Software Option	QPHY-ENET
	DBUS TDME SYMBOLIC	QualiPHY Enabled DDR2 Software Option	QPHY-DDR2
Decode, and Measure/Graph,		QualiPHY Enabled DDR3 Software Option	QPHY-DDR3
and Eye Diagram Option	- LUDOU CANIBUR TR	QualiPHY Enabled LPDDR2 Software Option	QPHY-LPDDR2
CAN Trigger & Decode Option	WR8K-CANBUS TD	QualiPHY Enabled MIPI D-PHY Software Option	
CAN Trigger, Decode, Measure/Graph, and Eye Diagram Option	WR8K-CANBUS TDME	QualiPHY Enabled MOST150Software Option	QPHY-MOST150
	NBUS TDME SYMBOLIC	QualiPHY Enabled MOST50 Software Option	QPHY-MOST50
Decode, and Measure/Graph,	INDOS IDIVIL STIVIDOLIO	QualiPHY Enabled USB 2.0 Software Option	QPHY-USB ‡
and Eye Diagram Option		10/100/1000Base-T Ethernet Test Fixture	TF-ENET-B**
DigRF 3G Bus Decode Option	WR8K-DigRF3Gbus D	USB 2.0 Compliance Test Fixture	TF-USB-B
DigRF V4 Bus Decode Option	WR8K-DigRFV4bus D	* TF-ENET-B required.  ‡ TF-USB-B required.	
MIPI D-PHY CSI-2, DSI Bus Decode Option	WR8K-DPHYbus D	** Includes ENET-2CAB-SMA018 and ENET-2ADA-BNC	SMA.
MIPI D-PHY CSI-2, DSI Bus Decode and	WR8K-DPHYbus DP		
Physical Layer Test Option		Serial Data Analysis	
ENET Bus Decode Option	WR8K-ENETbus D	Cable De-Embedding Option	WR8K-CBL-DE-EMBED
Bundle: Includes I2C, SPI, UART-RS232	WR8K-EMB TD	Eye Doctor (Virtual Probe and Equalizer	WR8K-EYEDRII
Trigger and Decode Option	W/DOL/ ENAD TOME	Emulation Bundle)	
Bundle: Incl. I2C, SPI, UART-RS232 Trigger, Decode, Measure/Graph, and	WR8K-EMB TDME	Serial Data Mask Software Option	WR8K-SDM
Eye Diagram Option		SDAII Serial Data Analysis Option	WR8K-SDAII
FibreChannel decode annotation Option	WR8K-FCbus D	DDD Dalama Tarallaka	
FlexRay Trigger and Decode Option	WR8K-FLEXRAYBUS TD	DDR Debug Toolkits	WDOL DDDO TOOLKIT
	R8K-FLEXRAYBUS TDMP	DDR2 and LPDDR2 Debug Toolkit DDR3, DDR3L, LPDDR3, DDR2, and	WR8K-DDR2-TOOLKIT WR8K-DDR3-TOOLKIT
Graph and Physical Layer Option		LPDDR2 Debug Toolkit	WR8R-DDR3-100LKII
I2C Trigger and Decode Option	WR8K-I2CBUS TD		WR8K-UPG-DDR3-TOOLKIT
I2C Trigger, Decode, Measure/Graph,	WR8K-I2CBUS TDME	LPDDR2 Debug Toolkit Upgrade	Whok-of G-DDh3-100EKI1
and Eye Diagram Option	WDOLL INDUO TO	Li DDN2 Debug Toolkit Opgrade	
LIN Trigger and Decode Option	WR8K-LINBUS TD	Data Storage Software	
LIN Trigger, Decode, Measure/Graph, and Eye Diagram Option	WR8K-LINBUS TDME	Advanced Optical Recording Measurement Pac	kage WR8K-AORM
	88K-MANCHESTERbus D	Disk Drive Measurements Software Package	WR8K-DDM2
MIPI M-PHY Bus Decode Option	WR8K-MPHYbus D	Disk Drive Analyzer Software Package	WR8K-DDA
MIPI M-PHY Bus Decode and Physical	WR8K-MPHYbus DP		
Layer Test Option		Power Analysis Software	
NRZ Bus Decode Option	WR8K-NRZbus D	Power Analyzer Software Option	WR8K-PWR
PCIe Gen 1 Decode Option	WR8K-PClebus D	, , , , , , , , , , , , , , , , , , , ,	
Serial Debug Toolkit - Measure Analyze	WR8K-PROTOBUS MAG	Jitter Analysis Software	
Graph Option		Clock, Clock-Data Jitter Analysis And Views Of	Time, WR8K-JITKIT
Decode Annotation and Protocol	WR8K-ProtoSync	Statistical, Spectral, and Jitter Overlay	•
Analyzer Synchronization Option	WDOL/ Droto Cupa DT		
Decode Annotation and Protocol Analyzer+Bit Tracer Synchronization Option	WR8K-ProtoSync-BT	Other Software Options	
SAS Decode annotation Option	WR8K-SASbus D	Advanced Customization Option	WR8K-XDEV
SATA Trigger and Decode Option	WR8K-SATAbus TD	EMC Pulse Parameter Software Option	WR8K-EMC
SENT Bus Decode Option	WR8K-SENTbus D	Electrical Telecom Mask Test Software Option	WR8K-ET-PMT
	WR8K-SPACEWIREbus D	Q-Scape Multi-tab Display Option	WR8K-Q-SCAPE
SPI Trigger and Decode Option	WR8K-SPIBUS TD	Spectrum Analyzer and Advanced FFT Option	WR8K-SPECTRUM
SPI Trigger, Decode, Measure/Graph,	WR8K-SPIBUS TDME		
and Eye Diagram Option		Digital Filtering Software	
	R8K-UART-RS232BUS TD	Digital Filter Software Option	WR8K-DFP2
	-UART-RS232BUS TDME		
Measure/Graph, and Eye Diagram Option			

# ORDERING INFORMATION

Product Description	Product Code	Product Description	Product Code
Remote Control/Network Options		Probes (cont'd)	
External USB2 to GPIB Adaptor	USB2-GPIB	1 Ch, 100 MHz Differential Amplifier with Precision Voltage Source	DA1855A
General Accessories		DA1855A with Rackmount	DA1855A-RM
Oscilloscope Cart with Additional Shelf and Drawer	OC1024	2 Ch, 100 MHz Differential Amplifier	DA1855A-PR2
Oscilloscope Cart	OC1021	with Precision Voltage Source	DA10FFA DD0 DM
Rackmount, 8U Adaptor Kit	WR8K-RACK	DA1855A with Rackmount (must be ordered at time of purchase, no retrofit)	DA1855A-PR2-RM
Keyboard, USB	KYBD-1	30 A; 50 MHz Current Probe – AC/DC; 30 Arms;	CP030
Soft Carrying Case	WR8K-SOFTCASE	50 Apeak Pulse	
Probes		30A, 50 MHz High Sensitivity Current Probe - AC/DC, 30 A rms, 50 A Peak Pulse, 1.5 meter cable	CP030A
High Voltage Fiber Optic Probe, 60 MHz	HVF0103	30 A; 100 MHz Current Probe – AC/DC; 30 Arms;	CP031
(requires accessory tip)		50 Apeak Pulse	
±1V (1x) Tip Accessory for HVF0103	HVF0100-1X-TIP	30A, 100 MHz High Sensitivity Current Probe -	CP031A
±5V (5x) Tip Accessory for HVF0103	HVF0100-5X-TIP	AC/DC, 30 A rms, 50 A Peak Pulse, 1.5 meter cable 150 A: 10 MHz Current Probe – AC/DC:	CP150
±20V (20x) Tip Accessory for HVF0103	HVF0100-20X-TIP	150 A, 10 MHZ Current Probe – AC/DC, 150 Arms; 500 Apeak Pulse	CP150
Power/Voltage Rail Probe. 4 GHz bandwidth, 1.2x at-	RP4030	500 A; 2 MHz Current Probe – AC/DC;	CP500
tenuation, ±30V offset, ±800mV		500 Arms; 700 Apeak Pulse	
Browser for use with RP4030	RP4000-BROWSER	Deskew Calibration Source for CP030, CP030A, CP031,	DCS025
500 MHz Passive Probe, 2.5mm, 10:1, 10 MΩ 500 MHz Passive Probe, 5mm, 10:1, 10 MΩ	PP022 PP024	CP031A, AP015, CP150, CP500	
1 GHz, 0.9 pF, 1 M $\Omega$ High Impedance Active Probe	ZS1000	Programmable Current Sensor to ProBus Adapter for use with third party current sensors	CA10
Set of 4 ZS1000, 1 GHz, 0.9 pF,	ZS1000-OUADPAK	Set of 4 CA10 Programmable Current Sensor to	CA10-OUADPAK
1 MΩ High Impedance Active Probe	201000 Q0/1217110	ProBus Adapters for third-party current sensors	0/110 Q0/1D1/110
1.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS1500	100:1 400 MHz 50 MΩ 1 kV High-voltage Probe	HVP120
Set of 4 ZS1500, 1.5 GHz, 0.9 pF,	ZS1500-QUADPAK	100:1 400 MHz 50 MΩ 4 kV High-Voltage Probe	PPE4KV
1 MΩ High Impedance Active Probe	700500	1000:1 400 MHz 50 M $\Omega$ 5 kV High-Voltage Probe	PPE5KV
2.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe Set of 4 ZS2500, 2.5 GHz, 0.9 pF,	ZS2500 ZS2500-QUADPAK	1000:1 400 MHz 5 M $\Omega$ / 50 M $\Omega$ 6 kV High-Voltage Probe	
1 MΩ High Impedance Active Probe	Z3Z3UU-QUADPAN	TekProbe to ProBus Probe Adapter	TPA10
500 MHz, 3.1pf, 1 MQ Active Differential Probe, ±40 V, with 10X Gain, 42V common-mode 200 MHz,	AP033	Set of 4 TPA10 TekProbe to ProBus Probe Adapters. Includes soft carrying case	TPA10-QUADPAK
4 GHz, 0.6 pF, 1 MΩ High Impedance Active Probe	ZS4000	Optical-to-Electrical Converter, 500-870 nm ProBus	OE425
200 MHz, 3.5 pF, 1 MΩ Active Differential Probe, ±20 V	ZD200	BNC Connector	05455
500 MHz, 1.0 pF Active Differential Probe, ±8 V	ZD500	Optical-to-Electrical Converter, 950-1630 nm ProBus BNC Connector	OE455
1 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1000	1kV, 25 MHz High Voltage Differential Probe	HVD3102
1.5 GHz, 1.0 pF Active Differential Probe, ±8 V	ZD1500	1kV, 25 MHz High Voltage Differential	HVD3102-NOACC
WaveLink 4 GHz, 2.5 Vp-p Differential Probe System	D410-A-PS	Probe without tip Accessories	11VD3102 NOA00
WaveLink 4 GHz, 5 Vp-p Differential Probe System	D420-A-PS	1kV, 120 MHz High Voltage Differential Probe	HVD3106
WaveLink 6 GHz, 2.5 Vp-p Differential Probe System	D610-A-PS	1kV, 120 MHz High Voltage Differential	HVD3106-NOACC
WaveLink 6 GHz, 5 Vp-p Differential Probe System WaveLink 4 GHz Differential Amplifier Module	D620-A-PS D400A-AT*	Probe without tip Accessories	1 11 / 12 00 0 0
waveLink 4 GHZ Differential Amplifier Module with Adjustable Tip	D400A-A1^	2kV, 120 MHz High Voltage Differential Probe	HVD3206
WaveLink 6 GHz Differential Amplifier Module with Adjustable Tip	D600A-AT*	2kV, 80 MHz High Voltage Differential Probe with 6m cable	HVD3206-6M
WaveLink ProBus Platform/Cable Assembly (4 GHz)	WL-PBus-CASE	6kV, 100 MHz High Voltage Differential Probe	HVD3605
	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	700 V, 15 MHz High-Voltage Differential Probe (÷10, ÷10	00) AP031





1-800-5-LeCroy teledynelecroy.com

Local sales offices are located throughout the world. Visit our website to find the most convenient location.

© 2017 by Teledyne LeCroy, Inc. All rights reserved. Specifications, prices, availability, and delivery subject to change without notice. Product or brand names are trademarks or requested trademarks of their respective holders.

PCI Express® is a registered trademark and/or service mark of PCI-SIG.

MATLAB® is a registered trademark of The MathWorks, Inc. All other product or brand names are trademarks or requested trademarks of their respective holders.